

<b>Notice of References Cited</b>	Application/Control No. 10/539,758		Applicant(s)/Patent Under Reexamination ANTONISSEN ET AL.	
	Examiner CHRISTINE CHEN		Art Unit 1793	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	I	US-			
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	K	US-			
	L	US-			
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	U				
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